

AP04N20GK-HF-VB Datasheet N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200)			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	1.2			
Q _g (Max.) (nC)	8.2				
Q _{gs} (nC)	1.8				
Q _{gd} (nC)	4.5				
Configuration	Single				

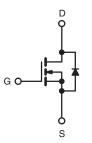
FEATURES

- Available in tape and reel
- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- Ease of paralleling
- Simple drive requirements









N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200	.,	
Gate-Source Voltage			V_{GS}	± 20	_ V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I-	1.0		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	ID	0.8	Α	
Pulsed Drain Current ^a			I _{DM}	5.0		
Linear Derating Factor				0.025	W/°C	
Linear Derating Factor (PCB Mount) e				0.017	¬	
Single Pulse Avalanche Energy b			E _{AS}	50	mJ	
Repetitive Avalanche Current ^a	etitive Avalanche Current ^a I _{AR} 0.96		Α			
Repetitive Avalanche Energy ^a			E _{AR}	0.31	mJ	
Maximum Power Dissipation	T _C =	T _C = 25 °C		3.1	W	
Maximum Power Dissipation (PCB Mount) e	T _A =	T _A = 25 °C		P _D 2.0		
Peak Diode Recovery dV/dt ^c	•		dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stq} -55 to +1	-55 to +150		
Soldering Recommendations (Peak Temperature)	d for	10 s		300	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 81 mH, R_G = 25 Ω , I_{AS} = 0.96 A (see fig. 12). c. $I_{SD} \le 3.3$ A, $dI/dt \le 70$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

服务热线:400-655-8788

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THERMAL RESISTANCE RATI	NGS				
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	40	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	60	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.30	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} =	$= V_{GS}, I_D = 250 \mu A$	2.0	-	4.0	V
Gate-Source Leakage	I_{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 200 V, V _{GS} = 0 V	-		25	μA
Zero date voltage Brain Garrent	טאי	V _{DS} = 160 \	/, V _{GS} = 0 V, T _J = 125 °C	-		250	μ, τ
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V}$	$I_D = 0.58 \text{ A}^{\text{ b}}$	-	1.2	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 0.58 A		0.51	-	-	S
Dynamic							
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	140	-	
Output Capacitance	C_{oss}			-	53	-	рF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	15	-	
Total Gate Charge	Qg			-	-	8.2	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 3.3 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 b	-	-	1.8	
Gate-Drain Charge	Q _{gd}	See lig. 0 and 13 -		-	-	4.5]
Turn-On Delay Time	t _{d(on)}			-	8.2	-	
Rise Time	t _r	V_{DD} = 100 V, I_{D} = 3.3 A, R_{g} = 24 Ω , R_{D} = 30 Ω , see fig. 10 b		-	17	-	ns
Turn-Off Delay Time	t _{d(off)}			-	14	-	
Fall Time	t _f			-	8.9	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	nH
Internal Source Inductance	L _S			-	6.0	-	11111
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	1	0.96	A
Pulsed Diode Forward Current ^a	I _{SM}			-	=	7.7	
Body Diode Voltage	V _{SD}	T _J = 25 °C,	$T_J = 25 ^{\circ}\text{C}, I_S = 0.96 \text{A}, V_{GS} = 0 \text{V}^{ \text{b}}$		-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.3 A, dl/dt = 100 A/μs b		-	150	310	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.60	1.4	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

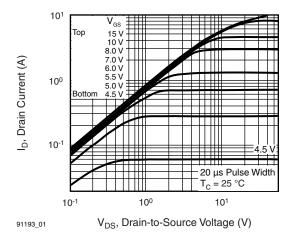


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

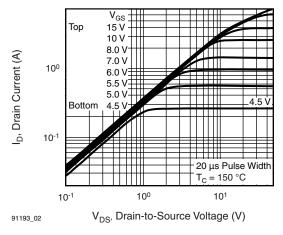


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

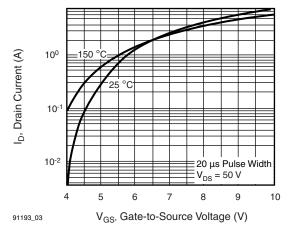


Fig. 3 - Typical Transfer Characteristics

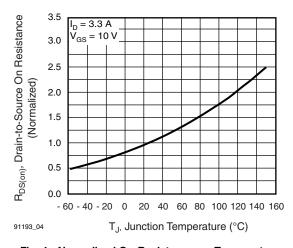


Fig. 4 - Normalized On-Resistance vs. Temperature

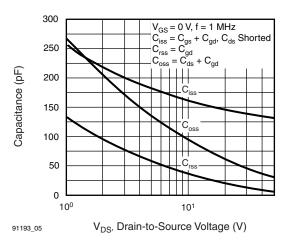


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

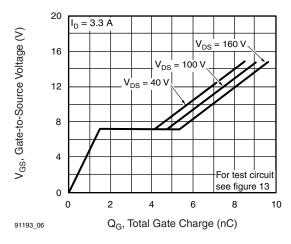


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



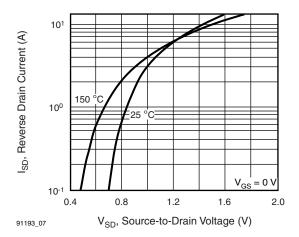


Fig. 7 - Typical Source-Drain Diode Forward Voltage

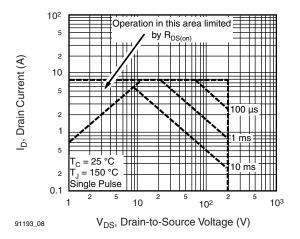


Fig. 8 - Maximum Safe Operating Area

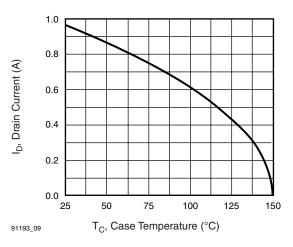


Fig. 9 - Maximum Drain Current vs. Case Temperature

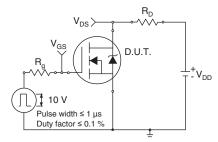


Fig. 10a - Switching Time Test Circuit

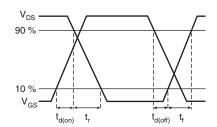


Fig. 10b - Switching Time Waveforms

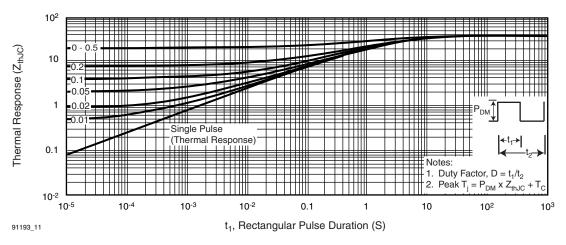


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



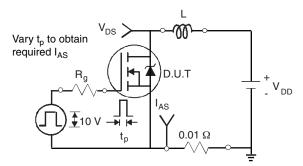


Fig. 12a - Unclamped Inductive Test Circuit

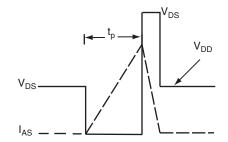


Fig. 12b - Unclamped Inductive Waveforms

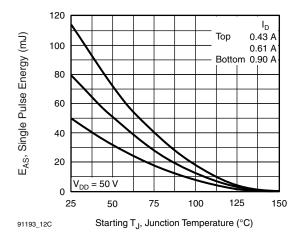


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

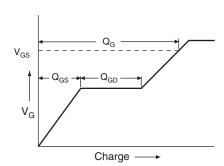


Fig. 13a - Basic Gate Charge Waveform

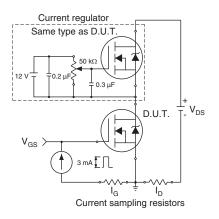
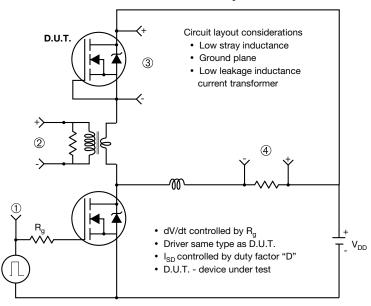


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



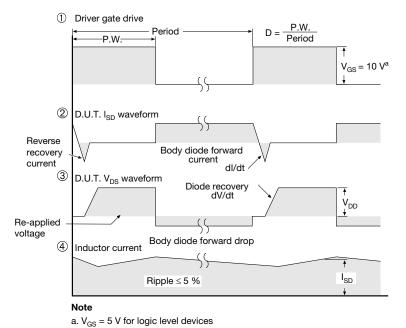
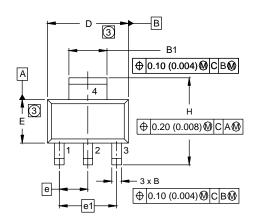
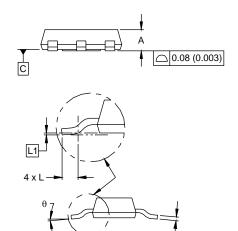


Fig. 14 - For N-Channel



SOT-223





	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
Α	1.55	1.80	0.061	0.071
В	0.65	0.85	0.026	0.033
B1	2.95	3.15	0.116	0.124
С	0.25	0.35	0.010	0.014
D	6.30	6.70	0.248	0.264
E	3.30	3.70	0.130	0.146
е	2.30 BSC		0.090	5 BSC
e1	4.60 BSC		0.181	BSC
Н	6.71	7.29	0.264	0.287
L	0.91	-	0.036	-
L1	0.061 BSC		0.002	4 BSC
θ	-	10'	-	10'

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.



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